

Search Notes

Application No.

10/645,611

Examiner

Ngan Ngo

Applicant(s)

YAMAZAKI ET AL.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
257	350	6-17-04	nm

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR